SN74SSTV16859 13-BIT TO 26-BIT REGISTERED BUFFER WITH SSTL 2 INPUTS AND OUTPUTS

DGG PACKAGE (TOP VIEW)

SCES297D - FEBRUARY 2000 - REVISED AUGUST 2004

🛮 V_{DDQ}

63 | GND

62 **∏** D13

∏ D12 61

54 ∏ GND

49 TCLK

Member of the Texas Instruments Widebus™ Family

1-to-2 Outputs to Support Stacked DDR

- Supports SSTL_2 Data Inputs
- **Outputs Meet SSTL 2 Class II Specifications**
- Differential Clock (CLK and CLK) Inputs
- Supports LVCMOS Switching Levels on the **RESET** Input
- **RESET** Input Disables Differential Input Receivers, Resets All Registers, and **Forces All Outputs Low**
- **Pinout Optimizes DIMM PCB Layout**
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- **ESD Protection Exceeds JESD 22**
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)

description/ordering information

This 13-bit to 26-bit registered buffer is designed for 2.3-V to 2.7-V V_{CC} operation.

All inputs are SSTL_2, except the LVCMOS reset (RESET) input. All outputs are SSTL_2, Class II compatible.

The SN74SSTV16859 operates from a differential clock (CLK and CLK). Data are registered at the crossing of CLK going high and CLK going low.

Q12A 2 Q11A 🛮 3 Q10A Π 4 Q9A 🛮 5 V_{DDQ} **[**] 6 GND 17 Q8A [] 8 Q7A 🛮 9

Q5A [] 11

Q1A Π 16

Q13A

60 VCC 59 V_{DDQ} 58 | GND 57 **∏** D11 56 **∏** D10 Q6A 1 10 55 D9

53 **D** D8 Q4A | 12 Q3A ∏ 13 52 **∏** D7 Q2A [14 51 RESET GND [] 15 50 | GND

Q13B **1**7 48 ∏ CLK 47 🛮 V_{DDQ} V_{DDQ} \cup{L} 18 46 🛮 V_{CC} Q12B [] 19 45 🛮 V_{REF} Q11B ¶ 20 Q10B 21 44 | D6

Q9B [22 43 | GND Q8B [23 42 D5 Q7B **1** 24 41 **∏** D4 Q6B ¶ 25 40 T D3 39 | GND GND **1** 26 38 [] V_{DDQ} V_{DDQ} [] 27

37 🛮 V_{CC} Q5B [] 28 Q4B **1** 29 36 **∏** D2 Q3B [] 30 35 D1 Q2B **∏** 31 34 | GND Q1B 32 33 🛮 V_{DDQ}

ORDERING INFORMATION

TA	PACKAGE [†]		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	QFN – RGQ (Tin–Pb Finish)	Topo and real	SN74SSTV16859RGQR	SS859
0°C to 70°C	QFN – RGQ (Matte–Tin Finish)	Tape and reel	SN74SSTV16859RGQ8	33039
	TSSOP – DGG	Tape and reel	SN74SSTV16859DGGR	SSTV16859

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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SN74SSTV16859 13-BIT TO 26-BIT REGISTERED BUFFER WITH SSTL 2 INPUTS AND OUTPUTS

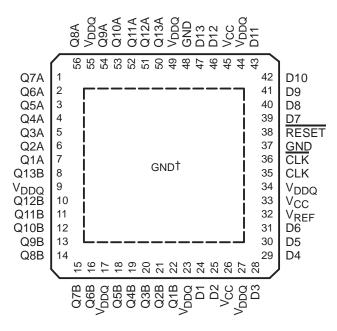
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description/ordering information (continued)

The device supports low-power standby operation. When $\overline{\text{RESET}}$ is low, the differential input receivers are disabled, and undriven (floating) data, clock, and reference voltage (V_{REF}) inputs are allowed. In addition, when $\overline{\text{RESET}}$ is low, all registers are reset, and all outputs are forced low. The LVCMOS $\overline{\text{RESET}}$ input always must be held at a valid logic high or low level.

To ensure defined outputs from the register before a stable clock has been supplied, RESET must be held in the low state during power up.

RGQ PACKAGE (TOP VIEW)



[†] The center die pad must be connected to GND.

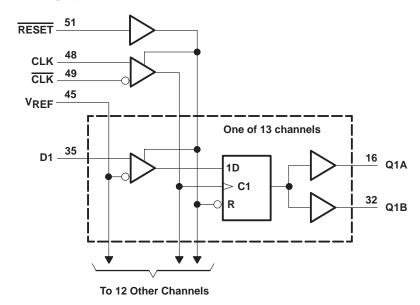
FUNCTION TABLE

	INPUTS										
RESET	CLK	Q									
Н	1	\downarrow	Н	Н							
Н	\uparrow	\uparrow \downarrow		L							
Н	L or H	L or H	Χ	Q_0							
L	X or floating	X or floating	X or floating	L							



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logic diagram (positive logic)



Pin numbers shown are for the DGG package.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC} or V _{DDQ}	–0.5 V to 3.6 V
Input voltage range, V _I (see Notes 1 and 2)	\dots -0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Notes 1 and 2)	$-0.5 \text{ V to V}_{DDQ} + 0.5 \text{ V}$
Input clamp current, $I_{ K }(V_{ C } < 0)$	–50 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{DDQ})	±50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{DDQ})$	±50 mA
Continuous current through each V _{CC} , V _{DDQ} , or GND	±100 mA
Package thermal impedance, θ _{JA} (see Note 3): DGG package	55°C/W
(see Note 4): RGQ package	22°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. This value is limited to 3.6 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51-7.
 - 4. The package thermal impedance is calculated in accordance with JESD 51-5.



SN74SSTV16859 13-BIT TO 26-BIT REGISTERED BUFFER WITH SSTL 2 INPUTS AND OUTPUTS

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recommended operating conditions (see Note 5)

			MIN	NOM	MAX	UNIT
Vсс	Supply voltage	V_{DDQ}		2.7	V	
V_{DDQ}	Output supply voltage	Output supply voltage				V
V _{REF}	Reference voltage ($V_{REF} = V_{DDQ}/2$)		1.15	1.25	1.35	V
VTT	Termination voltage		V _{REF} - 40 mV	VREF	V _{REF} + 40 mV	V
٧ _I	Input voltage		0		VCC	V
VIH	AC high-level input voltage	Data inputs	V _{REF} + 310 mV			V
V _{IL}	AC low-level input voltage	Data inputs			V _{REF} -310 mV	V
٧ _{IH}	DC high-level input voltage	Data inputs	V _{REF} + 150 mV			V
V_{IL}	DC low-level input voltage	Data inputs			V _{REF} - 150 mV	V
VIH	High-level input voltage	RESET	1.7			V
V _{IL}	Low-level input voltage	RESET			0.7	V
VICR	Common-mode input voltage range	CLK, CLK	0.97		1.53	V
V _{I(PP)}	Peak-to-peak input voltage	CLK, CLK	360			mV
IOH	High-level output current	•			-20	
lOL	Low-level output current				20	mA
TA	Operating free-air temperature		0		70	°C

NOTE 5: The RESET input of the device must be held at valid logic voltage levels (not floating) to ensure proper device operation. The differential inputs must not be floating unless RESET is low. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		v _{CC} †	MIN	TYP‡	MAX	UNIT
VIK	$I_{I} = -18 \text{ mA}$						-1.2	V
V		$I_{OH} = -100 \mu\text{A}$	2.3 V to 2.7 V	V _{DDQ} -	0.2		V	
VOH		I _{OH} = -16 mA	2.3 V	1.95			V	
\/ - ·		I _{OL} = 100 μA		2.3 V to 2.7 V			0.2	V
V _{OL}		I _{OL} = 16 mA		2.3 V			0.35	V
lį	All inputs	$V_I = V_{CC}$ or GND		2.7 V			±5	μΑ
la a	Static standby	RESET = GND]	2.7 V			10	μΑ
ICC	Static operating	$\overline{RESET} = V_{CC}, V_I = V_{IH(AC)} \text{ or } V_{IL(AC)}$		2.7 V			40	mA
	Dynamic operating – clock only	RESET = V _{CC} , V _I = V _{IH} (AC) or V _{IL} (AC), CLK and CLK switching 50% duty cycle RESET = V _{CC} , V _I = V _{IH} (AC) or V _{IL} (AC), CLK and CLK switching 50% duty cycle, One data input switching at one-half clock frequency, 50% duty cycle				30		μΑ/ MHz
ICCD	Dynamic operating – per each data input			2.5 V		10		μΑ/ clock MHz/ D input
rОН	Output high	I _{OH} = -20 mA		2.3 V to 2.7 V	7		20	Ω
rOL	Output low	I _{OL} = 20 mA		2.3 V to 2.7 V	7		20	Ω
r _{O(∆)}	rOH - rOL	$I_O = 20$ mA, $T_A = 25$ °C, One output		2.5 V			6	Ω
	Data inputs	V _I = V _{REF} ± 310 mV			2.5	3	3.5	
c _i §	CLK, CLK	V _{ICR} = 1.25 V, V _{I(PP)} = 360mV		2.5 V	2.5	3	3.5	pF
	RESET	V _I = V _{CC} or GND			3			

[†]For this test condition, V_{DDQ} always is equal to V_{CC}.

[§] Measured with 50-MHz input frequency for the QFN package and 10-MHz input frequency for the TSSOP package



[‡] All typical values are at $V_{CC} = 2.5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			V _{CC} = ± 0.2	2.5 V V†	UNIT	
			MIN	MAX		
fclock	clock Clock frequency					
t _W	Pulse duration, CLK, CLK high or low					
t _{act}	act Differential inputs active time (see Note 6)					
^t inact	Differential inputs inactive time (see Note 7)			22	ns	
	Setup time, fast slew rate (see Notes 8 and 10)	Pote hafara QUICT QUIC	0.75			
t _{su}	Setup time, slow slew rate (see Notes 9 and 10) Data before CLK↑, CLK↓				ns	
4.	Hold time, fast slew rate (see Notes 8 and 10)	0.75				
^t h	Hold time, slow slew rate (see Notes 9 and 10)	Data after CLK↑, CLK↓	0.9		ns	

 † For this test condition, $V_{\mbox{\scriptsize DDQ}}$ always is equal to $V_{\mbox{\scriptsize CC}}.$

NOTES: 6. VREF must be held at a valid input level, and data inputs must be held low for a minimum time of tact max, after RESET is taken high.

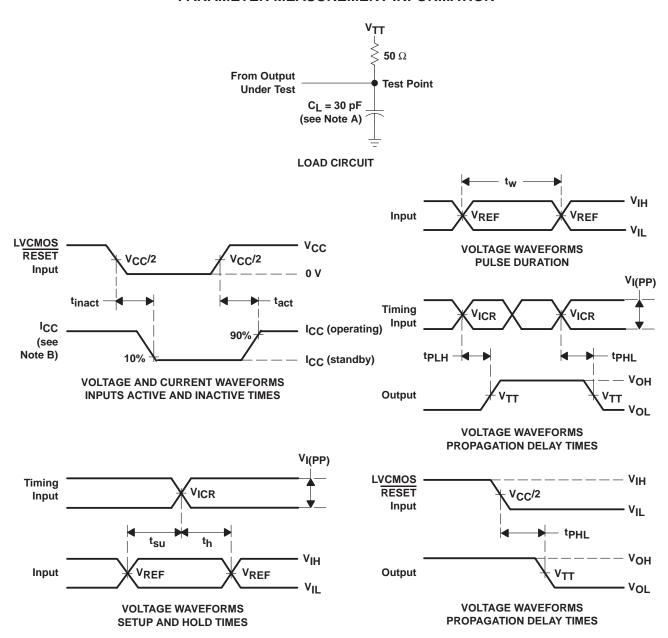
- 7. V_{REF}, data, and clock inputs must be held at valid voltage levels (not floating) for a minimum time of t_{inact} max, after RESET is taken
- 8. For data signal input slew rate ≥ 1 V/ns
- 9. For data signal input slew rate ≥ 0.5 V/ns and < 1 V/ns
- 10. CLK, CLK signals input slew rates are ≥ 1 V/ns.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO	V _{CC} = ± 0.2	2.5 V V [†]	UNIT
	(INPUT)	(OUTPUT)		MAX	
fmax			200		MHz
^t pd	CLK and CLK	Q	1.1	2.8	ns
^t PHL	RESET	Q		5	ns

 $^{^{\}dagger}$ For this test condition, $V_{\mbox{\scriptsize DDQ}}$ always is equal to $V_{\mbox{\scriptsize CC}}.$

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. I_{CC} tested with clock and data inputs held at V_{CC} or GND, and I_{O} = 0 mA.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, input slew rate = 1 V/ns \pm 20% (unless otherwise noted).
- D. The outputs are measured one at a time, with one transition per measurement.
- E. $V_{TT} = V_{REF} = V_{DDQ}/2$
- F. $V_{IH} = V_{REF} + 310 \text{ mV}$ (ac voltage levels) for differential inputs. $V_{IH} = V_{CC}$ for LVCMOS input.
- G. $V_{IL} = V_{REF} 310$ mV (ac voltage levels) for differential inputs. $V_{IL} = GND$ for LVCMOS input.
- H. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



www.ti.com 7-May-2025

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
SN74SSTV16859DGGR	Active	Production	TSSOP (DGG) 64	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	SSTV16859
SN74SSTV16859RGQ8	Obsolete	Production	VQFN (RGQ) 56	-	-	Call TI	Call TI	0 to 70	SS859

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

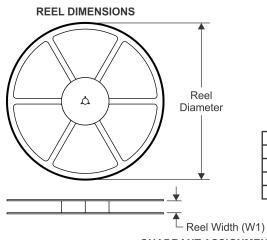
⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

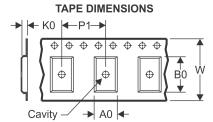
⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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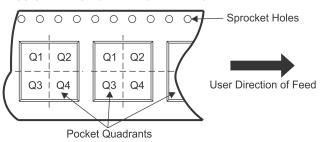
TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



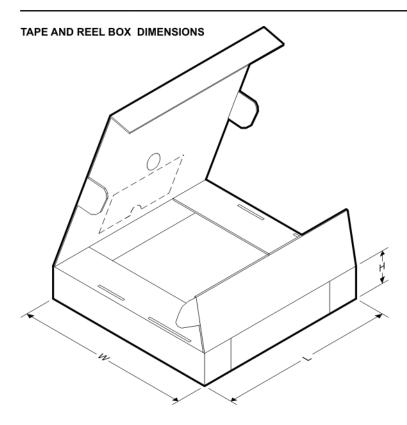
*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74SSTV16859DGGR	TSSOP	DGG	64	2000	330.0	24.4	8.4	17.3	1.7	12.0	24.0	Q1



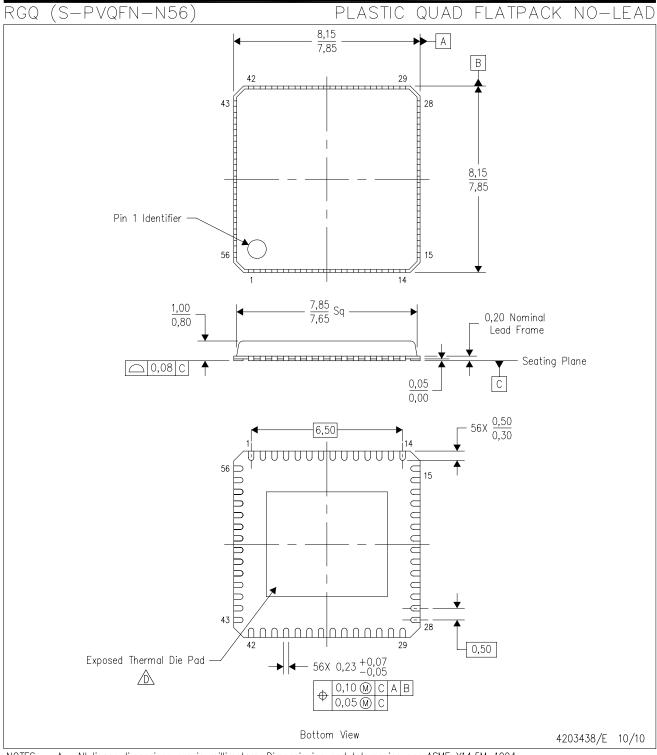
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*All dimensions are nominal

ĺ	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
I	SN74SSTV16859DGGR	TSSOP	DGG	64	2000	367.0	367.0	45.0



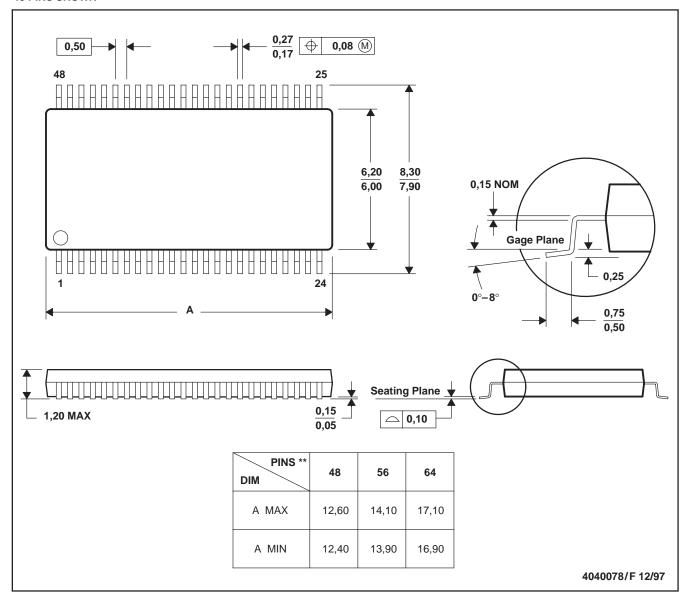
- NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. QFN (Quad Flatpack No-Lead) Package configuration.
 - The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
 - E. Package complies to JEDEC MO-220 variation VLLD-2.



DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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